Se	arch N	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,056	SATO ET AL.	
Examiner	Art Unit	_
John S. Chu	1795	

	SEAR	CHED	
Class	Subclass	Date	Examiner
430	270.1	19/2007	ya c
430	905	1	(
430	910		
		_	
			,

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
East search in file		16 2007	jac
,			